Notice of References Cited Application/Control No. 10/726,677 Examiner James A. Dudek Applicant(s)/Patent Under Reexamination CHOO ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0207800	10-2004	Hiruma et al.	349/189
_	В	US-2004/0046925	03-2004	Matsuda, Akehiro	349/187
	С	US-2004/0012755	01-2004	Choo et al.	349/190
	D	US-2003/0184708	10-2003	Kweon et al.	349/189
	E	US-2003/0063251	04-2003	Murata et al.	349/189
	F	US-2002/0167638	11-2002	Byun et al.	349/187
	G	US-5,263,888	11-1993	Ishihara et al.	445/25
	Н	US-			
		US-			,
	J	US-		·	
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*	·	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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